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Key indicators

Single-crystal X-ray study
 $T = 293$ K
Mean $\sigma(\text{Si-O}) = 0.002$ Å
 R factor = 0.023
 wR factor = 0.064
Data-to-parameter ratio = 17.6For details of how these key indicators were
automatically derived from the article, see
<http://journals.iucr.org/e>.Parawollastonite-type $\text{Cd}_3[\text{Si}_3\text{O}_9]$

$\text{Cd}_3[\text{Si}_3\text{O}_9]$ (tricadmium trisilicate) crystallizes in the monoclinic space group $P2_1/c$ and is isotypic with the mineral parawollastonite, $\text{Ca}_3[\text{Si}_3\text{O}_9]\cdot 2M$. The structure contains distorted CdO_6 octahedra and SiO_4 tetrahedra that are organized in unbranched dreier single chains with three SiO_4 tetrahedra in the repeat unit. All atoms occupy general positions $4e$.

Received 5 May 2005
Accepted 13 May 2005
Online 21 May 2005

Comment

Cadmium silicates are of particular interest because of their properties as host materials for luminescent applications when doped with rare earth or transition metal ions. Recently, some $\text{CdSiO}_3:RE$ phosphors ($RE = \text{rare earth}$) with a long-lasting phosphorescence upon UV-light excitation were reported (Liu *et al.*, 2005).

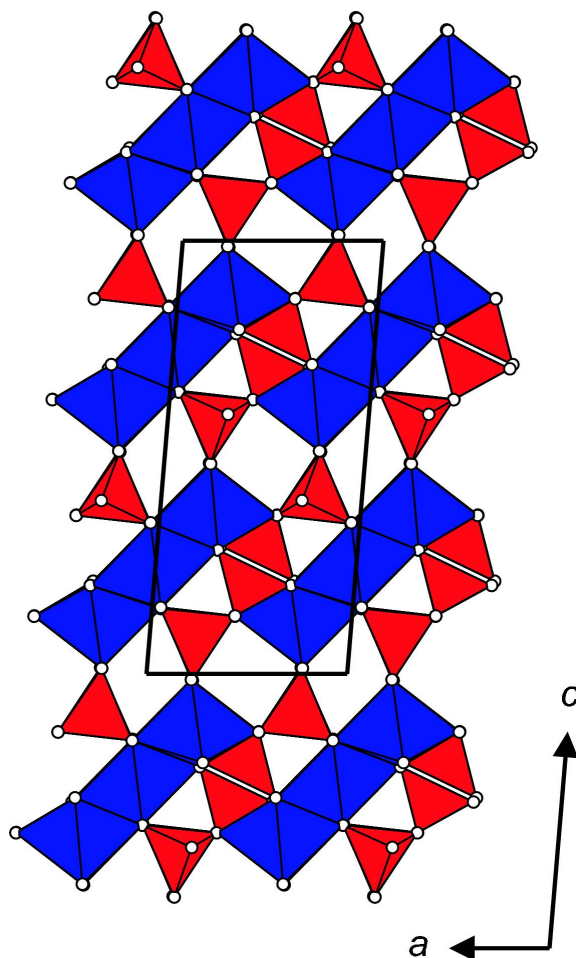


Figure 1
The crystal structure in polyhedral representation, projected along $[010]$.
Key: CdO_6 octahedra blue and SiO_4 tetrahedra red.

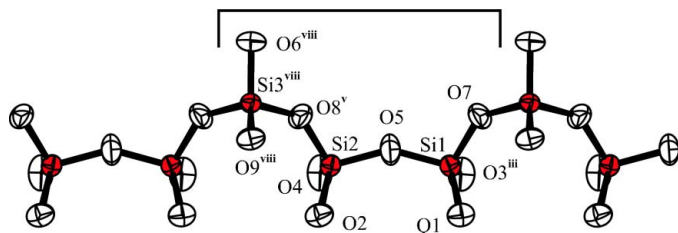


Figure 2

Part of a dreier single chain with atom labelling and indicated periodicity which corresponds with the length of the *b* axis. Displacement ellipsoids are drawn at the 97% probability level. Symmetry codes are as given in Table 1.

In the system CdO–SiO₂, three compounds are known to exist: the orthosilicate Cd₂SiO₄ which crystallizes in the thenardite structure type (Dent Glasser & Glasser, 1964), the oxyorthosilicate Cd₃OSiO₄ with a unique structure (Eysel, 1970), and the polysilicate CdSiO₃ for which only powder data were published (Dent Glasser & Glasser, 1964). In the original work, it was not possible to determine the space group of CdSiO₃ unequivocally because the crystals were polysynthetically twinned. However, powder data revealed a structural relation to the calcium analogue, CaSiO₃. The latter occurs in different polymorphs with structurally quite different arrangements. The high-temperature phase is a cyclosilicate called α -wollastonite or pseudowollastonite. Its structure contains rings of three corner-shared SiO₄ tetrahedra organized in a layered arrangement. Depending on the stacking sequence of the layers, a number of polytypes were reported for pseudowollastonite (Yamanaka & Mori, 1981). The low-temperature phases of calcium polysilicate are made up of unbranched single chains of corner-shared SiO₄ tetrahedra. Two polytypes have been reported for the low-temperature phase, often referred to as β -wollastonites. They are distinguished by the symbols *nT* and *nM*, where *T* and *M* symbolize the triclinic and monoclinic symmetry, and *n* indicates the number of subcells. The polytype *1T* is also named wollastonite whereas the polytype *2M* is a synonym for parawollastonite (Trojer, 1968; Hesse, 1984). For all polymorphs, the chemical formulae CaSiO₃, Ca₃(SiO₃)₃ or Cd₃[Si₃O₉] are reported in the literature.

Although it was reported that cadmium polysilicate can occur in different polytypes (Dent Glasser & Glasser, 1964), only the form that is isotypic with parawollastonite was obtained during the present investigation. In accordance with the nomenclature of condensed silicates given by Liebau (1985), the formula of the title compound is written as Cd₃[Si₃O₉].

The Cd₃[Si₃O₉] structure differs only slightly from that of the isotypic Ca phase (Hesse, 1984), mainly in changes in the Cd–O distances versus the Ca–O distances resulting from the different ionic radii (Shannon, 1976) of 0.95 (Cd²⁺; CN = 6) and 1.00 Å (Ca²⁺; CN = 6), respectively.

The three independent Cd atoms are each surrounded by six O atoms, forming distorted CdO₆ octahedra which are arranged in slabs parallel to [010]. Three such slabs constitute

ribbons which are separated from each other by unbranched silicate chains that are formed by corner-sharing SiO₄ tetrahedra (Fig. 1). The silicate chains have a repeating period of three SiO₄ tetrahedra (Fig. 2) which corresponds with the length of the *b* axis. According to Liebau's (1985) notation, Cd₃[Si₃O₉] is a dreier single chain polysilicate.

The mean Cd–O distances of 2.326 (Cd1), 2.333 (Cd2) and 2.341 Å (Cd3) are slightly shorter than the corresponding mean Ca–O distances of 2.385 (Ca1), 2.378 (Ca2) and 2.385 Å (Ca3), whereas the mean Si–O distances in Cd₃[Si₃O₉] and Ca₃[Si₃O₉] are virtually the same, *viz.* 1.620, 1.627 and 1.635 Å in the Cd compound versus 1.620, 1.617 and 1.630 Å in the Ca compound. The O–Si–O angles of the silicate chains are very similar in both isotypic structures and are in the range 102.06 (9)–122.12 (10)° in the Cd compound versus 102.5 (1)–122.0 (1)° in the Ca compound.

Experimental

CdCO₃ (Merck, p. A.) and high-surface silica (Degussa–Hüls) were mixed in the stoichiometric ratio 2:1 and slowly heated in a platinum crucible to 1023 K for 24 h. X-ray powder diffraction of the polycrystalline material revealed a mixture of Cd₂SiO₄ (Dent Glasser & Glasser, 1964) and Cd₃[Si₃O₉]. The mixture was then heated to 1473 K, left at that temperature for 2 h and cooled slowly to 1173 K at a rate of 4 K h^{−1}. The furnace was then shut down. After cooling to room temperature, the colourless melt was crushed and a plate-like single-crystal was used for the data collection. X-ray powder diffraction of the final product yielded Cd₃[Si₃O₉], isotypic with Ca₃[Si₃O₉]-*2M*, and only minor amounts of Cd₂SiO₄.

Crystal data

Cd ₃ [Si ₃ O ₉]	$D_x = 4.962 \text{ Mg m}^{-3}$
$M_r = 565.47$	Mo $K\alpha$ radiation
Monoclinic, $P2_1/c$	Cell parameters from 4479 reflections
$a = 6.9463 (8) \text{ \AA}$	$\theta = 2.7\text{--}31.2^\circ$
$b = 7.2563 (9) \text{ \AA}$	$\mu = 8.86 \text{ mm}^{-1}$
$c = 15.0697 (18) \text{ \AA}$	$T = 293 (2) \text{ K}$
$\beta = 94.791 (2)^\circ$	Plate, colourless
$V = 756.93 (16) \text{ \AA}^3$	$0.26 \times 0.14 \times 0.02 \text{ mm}$
$Z = 4$	

Data collection

Bruker SMART APEX CCD diffractometer	2412 independent reflections
ω scans	1980 reflections with $I > 2\sigma(I)$
Absorption correction: multi-scan (SADABS; Bruker, 2002)	$R_{\text{int}} = 0.037$
$T_{\text{min}} = 0.203$, $T_{\text{max}} = 0.816$	$\theta_{\text{max}} = 31.2^\circ$
8622 measured reflections	$h = -8 \rightarrow 9$
	$k = -10 \rightarrow 10$
	$l = -21 \rightarrow 19$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0215P)^2 + 1.0847P]$
$R[F^2 > 2\sigma(F^2)] = 0.024$	where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.064$	$(\Delta\rho)_{\text{max}} = 0.001$
$S = 1.07$	$\Delta\rho_{\text{max}} = 1.60 \text{ e \AA}^{-3}$
2412 reflections	$\Delta\rho_{\text{min}} = -1.38 \text{ e \AA}^{-3}$
137 parameters	Extinction correction: SHELXL97
	Extinction coefficient: 0.00358 (19)

Table 1
Selected geometric parameters (Å, °).

Cd1—O6	2.272 (2)	Cd3—O8	2.3743 (16)
Cd1—O1 ⁱ	2.3045 (18)	Cd3—O6	2.4293 (18)
Cd1—O9 ⁱⁱ	2.317 (2)	Cd3—O9 ^{vii}	2.4573 (18)
Cd1—O2 ⁱⁱⁱ	2.3214 (19)	Si1—O3 ^{viii}	1.592 (2)
Cd1—O1	2.3519 (19)	Si1—O1	1.620 (2)
Cd1—O2	2.3869 (19)	Si1—O5	1.6219 (15)
Cd2—O4 ^{iv}	2.1681 (17)	Si1—O7	1.6447 (17)
Cd2—O3	2.2113 (17)	Si2—O4	1.602 (2)
Cd2—O1 ⁱ	2.260 (2)	Si2—O2	1.612 (2)
Cd2—O7 ^v	2.3939 (17)	Si2—O5	1.6158 (15)
Cd2—O6	2.4538 (18)	Si2—O8 ^v	1.6399 (17)
Cd2—O9 ^v	2.5102 (18)	Si3—O6	1.599 (2)
Cd3—O4 ^{vi}	2.2262 (17)	Si3—O9	1.605 (2)
Cd3—O2 ⁱⁱⁱ	2.249 (2)	Si3—O7 ^v	1.6529 (16)
Cd3—O3	2.3073 (17)	Si3—O8	1.6611 (16)
O3 ^{viii} —Si1—O1	115.83 (11)	O5—Si2—O8 ^v	102.69 (9)
O3 ^{viii} —Si1—O5	107.63 (9)	O6—Si3—O9	122.12 (10)
O1—Si1—O5	108.44 (9)	O6—Si3—O7 ^v	104.20 (9)
O3 ^{viii} —Si1—O7	114.32 (10)	O9—Si3—O7 ^v	111.27 (9)
O1—Si1—O7	107.54 (10)	O6—Si3—O8	103.48 (9)
O5—Si1—O7	102.06 (9)	O9—Si3—O8	111.02 (9)
O4—Si2—O2	115.78 (11)	O7 ^v —Si3—O8	102.80 (9)
O4—Si2—O5	106.92 (9)	Si2—O5—Si1	148.03 (13)
O2—Si2—O5	109.09 (9)	Si1—O7—Si3 ^{vii}	139.89 (11)
O4—Si2—O8 ^v	113.60 (10)	Si2 ^{viii} —O8—Si3	140.61 (11)
O2—Si2—O8 ^v	107.89 (10)		

Symmetry codes: (i) $-x, \frac{1}{2} + y, \frac{1}{2} - z$; (ii) $x - 1, y, z$; (iii) $-x, y - \frac{1}{2}, \frac{1}{2} - z$; (iv) $x, \frac{3}{2} - y, z - \frac{1}{2}$; (v) $1 - x, \frac{1}{2} + y, \frac{1}{2} - z$; (vi) $x, \frac{1}{2} - y, z - \frac{1}{2}$; (vii) $1 - x, y - \frac{1}{2}, \frac{1}{2} - z$; (viii) $x, \frac{1}{2} - y, \frac{1}{2} + z$.

The structure was initially refined in space group $P2_1/a$ with the atomic coordinates of the isotopic compound $\text{Ca}_3[\text{Si}_3\text{O}_9]\cdot 2M$ (parawollastonite; Hesse, 1984) as starting parameters. For the present refinement, the standard setting in $P2_1/c$ was used and the structural data were standardized using the program *STRUCTURE-TIDY* (Gelato & Parthé, 1987). The highest peak in the final Fourier map is 0.81 Å from atom Cd1 and the deepest hole is 1.64 Å from O8.

Data collection: *SMART* (Bruker, 2002); cell refinement: *SAINT* (Bruker, 2002); data reduction: *SAINT*; method used to solve structure: coordinates taken from the isotopic Ca compound; program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *ATOMS* (Dowty, 2004); software used to prepare material for publication: *SHELXL97*.

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